

Supplementary Materials

***In situ* monitoring of growth of vertically stacked h-BN/graphene heterostructures on Ni substrates and their interface interaction**

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More initial XPEEM results of vertical stacked h-BN/graphene heterostructures growth on Ni substrates

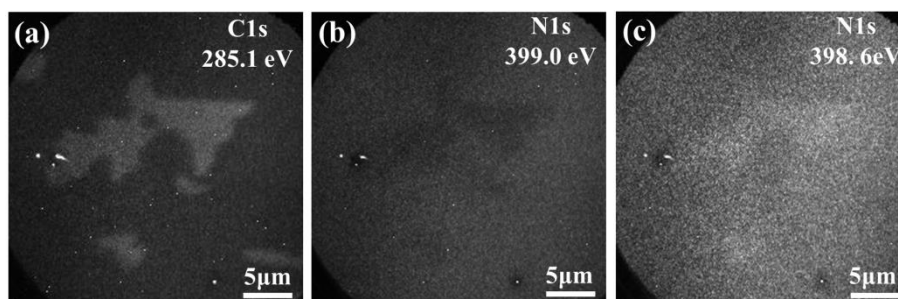


Figure S1 Initial XPEEM images at C 1s and N 1s core levels with binding energies of 285.1, 399.0, and 398.6 eV ($h\nu = 500$ eV) at the surface segregation temperature of 650 °C. The distribution of

related elements with the certain chemical state displays bright contrast.

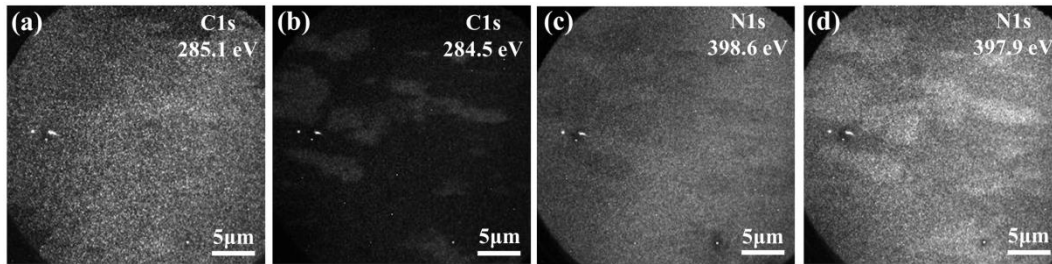


Figure S2 Initial XPEEM images at C 1s core levels with binding energies of 285.1 and 284.5 eV, and N 1s core levels with binding energies of 398.6 and 397.9 eV at the surface segregation temperature of 600 °C. The distribution of related elements with the certain chemical state displays bright contrast.